

2N7002CK

60 V, 0.3 A N-channel Trench MOSFET Rev. 01 — 11 September 2009

Product data sheet

Product profile

1.1 General description

ESD protected N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 3 kV

1.3 Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage		-	-	60	V
I_D	drain current		-	-	300	mA
I _{DM}	peak drain current	single pulse; $t_p \le 10 \mu s$	-	-	1.2	Α
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V};$ $I_D = 500 \text{ mA}$	-	1.1	1.6	Ω



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2. Pinning information

Table 2. Pinning

I dibio 2.	9			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		D
2	S	source	<u> 3</u>	D
3	D	drain	1 2	G T S

3. Ordering information

Table 3. Ordering information

Type number	Package	^l ackage				
	Name	Description	Version			
2N7002CK	TO-236AB	plastic surface-mounted package; 3 leads	SOT23			

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
2N7002CK	LP*

- [1] * = -: made in Hong Kong
 - * = p: made in Hong Kong
 - * = t: made in Malaysia
 - * = W: made in China

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5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$25~^{\circ}C \le T_j \le 150~^{\circ}C$	-	60	V
V_{GS}	gate-source voltage		-	±20	V
I _D	drain current	V _{GS} = 10 V			
		T _{amb} = 25 °C	-	300	mΑ
		T _{amb} = 100 °C	-	190	mΑ
I _{DM}	peak drain current	T_{amb} = 25 °C; $t_p \le 10 \mu s$	-	1.2	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C	<u>[1]</u> _	350	mW
Tj	junction temperature			150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C
Source-d	rain diode				
Is	source current	T _{amb} = 25 °C	-	200	mΑ
I _{SM}	peak source current	T_{amb} = 25 °C; $t_p \le 10 \mu s$	-	1.2	Α
ElectroSt	tatic Discharge (ESD)				
V _{ESD}	electrostatic discharge voltage	all pins; human body model; C = 100 pF; $R = 1.5 \text{k}\Omega$	-	3	kV

^[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².

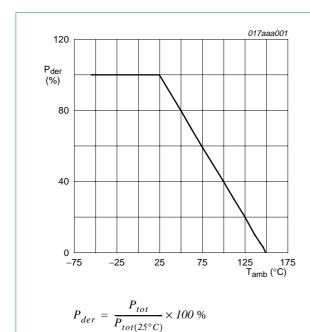
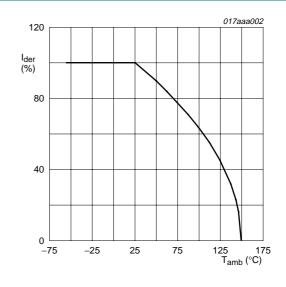


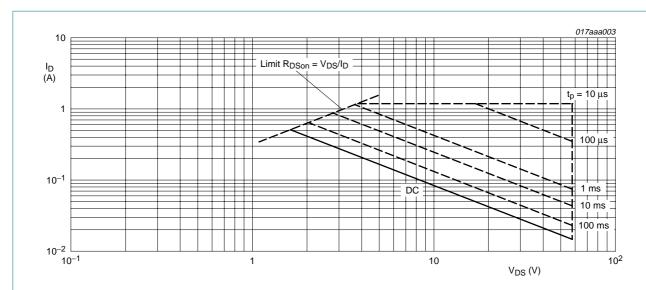
Fig 1. Normalized total power dissipation as a function of ambient temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

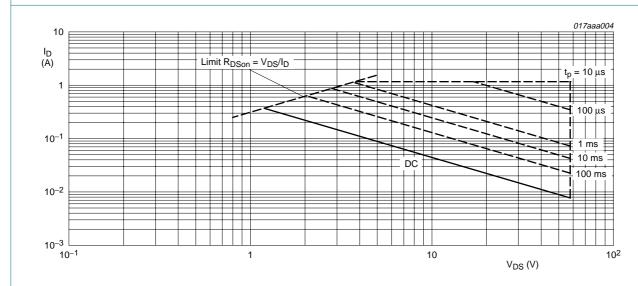
Fig 2. Normalized continuous drain current as a function of ambient temperature

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 T_{sp} = 25 °C; I_{DM} = single pulse; V_{GS} = 10 V

Fig 3. Safe operating area; junction to solder point; continuous and peak drain currents as a function of drain-source voltage



 T_{amb} = 25 °C; I_{DM} = single pulse; V_{GS} = 10 V

Fig 4. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from	in free air	<u>[1]</u> _	350	500	K/W
	junction to ambient					

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 Table 6.
 Thermal characteristics ...continued

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	150	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

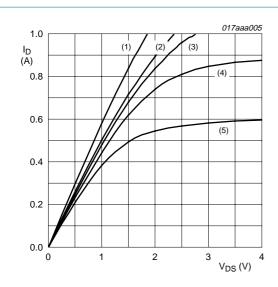
7. Characteristics

Table 7. Characteristics

 $T_{amb} = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source breakdown	$I_D = 10 \mu A; V_{GS} = 0 V$				
	voltage	T _j = 25 °C	60	-	-	V
		T _j = −55 °C	55	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS};$ $T_j = 25 ^{\circ}C$	1	1.75	2.5	V
I _{DSS}	drain leakage current	$V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	-	100	nΑ
		T _j = 150 °C	-	-	1	μΑ
I _{GSS}	gate leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	5	μΑ
		$V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$	-	50	450	nΑ
		$V_{GS} = \pm 5 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	100	nΑ
R _{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V};$ $I_D = 200 \text{ mA}$				
		T _j = 25 °C	-	1.3	3	Ω
		T _j = 150 °C	-	2.8	4.4	Ω
		$V_{GS} = 10 \text{ V}; I_D = 500 \text{ mA}$	-	1.1	1.6	Ω
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 200 \text{ mA};$	-	1.09	1.3	nC
Q_{GS}	gate-source charge	V _{DS} = 10 V; V _{GS} = 4.5 V	-	0.22	-	nC
Q_{GD}	gate-drain charge	VGS = 4.5 V	-	0.23	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$	-	47.2	55	pF
C _{oss}	output capacitance	f = 1 MHz	-	11	20	pF
C _{rss}	reverse transfer capacitance		-	5	7.5	pF
t _{d(on)}	turn-on delay time	V _{DS} = 15 V;	-	8	15	ns
t _r	rise time	$R_L = 15 \Omega;$ $V_{GS} = 10 V;$	-	8	15	ns
t _{d(off)}	turn-off delay time	$R_{G} = 6 \Omega$	-	38	50	ns
t _f	fall time	_	-	22	35	ns
Source-dr	ain diode					
V_{SD}	source-drain voltage	$I_S = 200 \text{ mA}; V_{GS} = 0 \text{ V}$	0.47	0.79	1.1	V

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(1)
$$V_{GS} = 10 \text{ V}$$

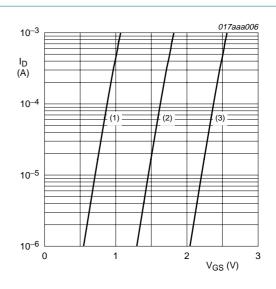
(2)
$$V_{GS} = 5 V$$

(3)
$$V_{GS} = 4.5 \text{ V}$$

(4)
$$V_{GS} = 4 V$$

(5)
$$V_{GS} = 3.5 \text{ V}$$

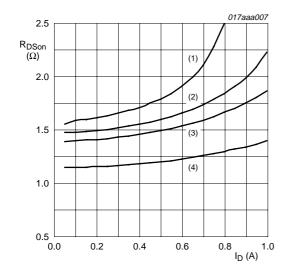
Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



$$T_{j} = 25 \,^{\circ}C; \, V_{DS} = 5 \,^{\circ}V$$

- (1) minimum values
- (2) typical values
- (3) maximum values





T_i = 25 °C

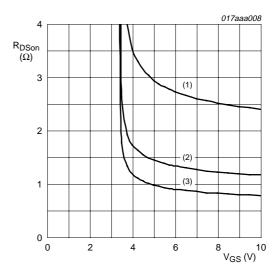
(1)
$$V_{GS} = 4 V$$

(2)
$$V_{GS} = 4.5 \text{ V}$$

(3)
$$V_{GS} = 5 V$$

(4)
$$V_{GS} = 10 \text{ V}$$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



 $I_D = 500 \text{ mA}$

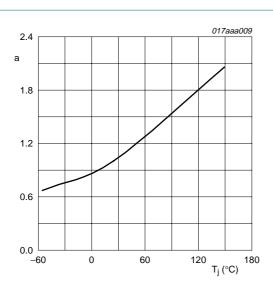
(1)
$$T_j = 150 \, ^{\circ}C$$

(2)
$$T_j = 25$$
 °C

(3)
$$T_j = -55 \,^{\circ}\text{C}$$

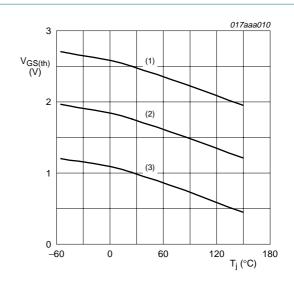
Fig 8. Drain-source on-resistance as a function of gate-source voltage; typical values

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$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

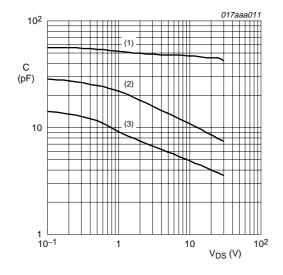
Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature



$$I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 10. Gate-source threshold voltage as a function of junction temperature

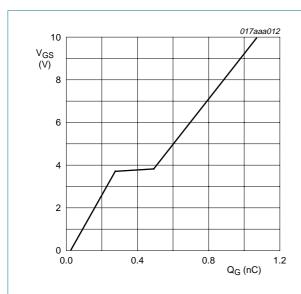


 $V_{GS} = 0 V; f = 1 MHz$

- (1) C_{iss}
- (2) Coss
- (3) Crss

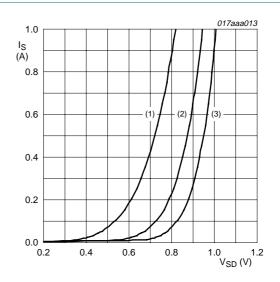
Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 I_D = 200 mA; V_{DD} = 30 V; T_j = 25 °C

Fig 12. Gate-source voltage as a function of gate charge; typical values



 $V_{GS} = 0 V$

(1) $T_j = 150 \, ^{\circ}C$

(2) $T_j = 25$ °C

(3) $T_j = -55 \,^{\circ}C$

Fig 13. Source current as a function of source-drain voltage; typical values

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8. Package outline

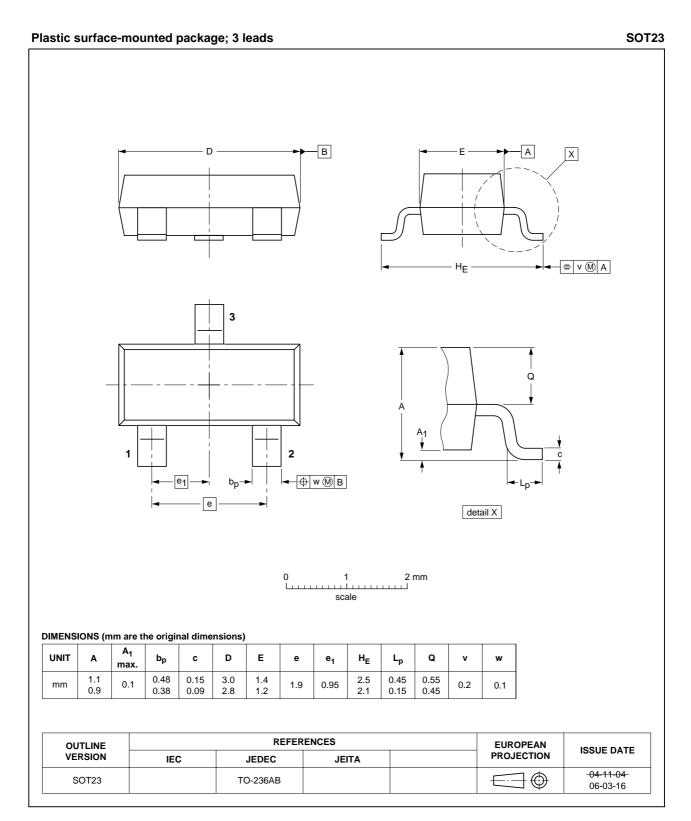
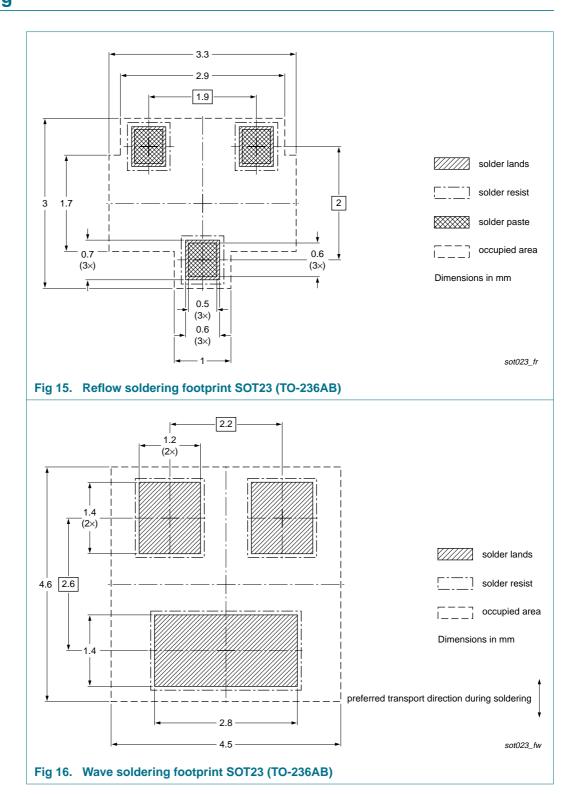


Fig 14. Package outline SOT23 (TO-236AB)

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9. Soldering



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10. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
2N7002CK_1	20090911	Product data sheet	-	-

60 V, 0.3 A N-channel Trench MOSFET

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11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Date of release: 11 September 2009

Document identifier: 2N7002CK_1